


<b>Search Notes</b>  	<b>Application/Control No.</b>  10595221	<b>Applicant(s)/Patent Under Reexamination</b>  TANAKA ET AL.
	<b>Examiner</b>  DEREK S CHAPEL	<b>Art Unit</b>  2872

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
Consulted with Arnel Lavarias about the restriction requirement.	2/25/2008	DSC
Consulted with Arnel Lavarias about the search	7/22/2008	DSC
Consulted with Audrey Chang about the case	7/25/2008	DSC
EAST Class/Subclass Search: 359/1, 9; 345/419-427, 619; 382/285 (text only)	7/25/2008	DSC
EAST Class Search 359/9	7/25/2008	DSC
EAST Update Search	4/4/2009	DSC
Consulted with Arnel Lavarias about the classification	4/9/2009	DSC

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
	see .clm. search	7/29/2008	DSC
	Updated .clm. search	4/4/2009	DSC

/D. S. C./ Examiner.Art Unit 2872	
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